

## **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

Electronic Version v18
Stylesheet Version v18.0

Title of Invention

METHODS AND APPARATUS FOR CREATING A HIGH SPEED CONNECTION BETWEEN A DEVICE UNDER TEST AND AUTOMATIC TEST EQUIPMENT

Application Number:

10/725966

- 1 ( **6 ) ( 1** ) ( 1 ) ( **1 )** ( **1 )** ( **1 )** ( **1 )** ( **1 )** ( **1 )** 

Confirmation Number:

2845

First Named Applicant:

**ROGER SINSHEIMER** 

Attorney Docket Number: XANDP004

ANDDOOA

Art Unit:

2855

Search string:

( 4589815 or 5068601 or 5552701 or

5923189 ).pn.

## **US Patent Documents**

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
R	1	4589815	1986-05-20	SMITH	]	414	590
ek	2	5068601	1991-11-26	PARMENTER	]	439	141
RK	3	5552701	1996-09-03	VETERAN ET AL.	]	324	158.1
RA	4	<del>-5023189</del>	1999-07-13	BOTKA ET AL.		324	758

5923/80

## Remarks

Note: Remarks are not for responding to an office action.

The Applicants are aware of various products offered by a variety of vendors which may be material to the examination of the above identified patent application. Such products include, for example, the IDS5K E beam Prober to F330 Tester from Sun-Microsystems, the IDS3K - S9K Tester from TSMC (of Taiwan), the IDS5K - J971 Tester from Meterola, and all IDS P2X systems docked to F330, S9K, or J971 from Motorola and/or Sun Microsystems.

Signature

APP ID=10725968

8-26-2004

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